

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/577,967	AHAD, RAFIUL	
Examiner	Art Unit	_
Mary J. Steelman	2191	

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	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Fast v 2.0.1.4 US Pat US PG Pols EPO TPO Denwert IBM Teck Bul	,1.9.05	m S		
Palm Inventor Name Scarch	11-8-05	m.s		
Won Patent Literature IEEE. ACM scholar. google, com	11. 9.05	m S		
Wei Zhen BPE 2191	11-7.05	m5		